

OptiMOS™-T2 Power-Transistor



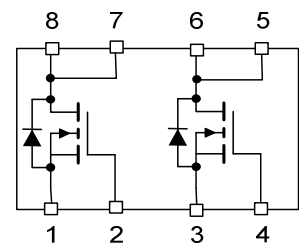
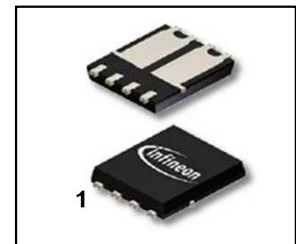
Features

- Dual N-channel Normal Level - Enhancement mode
- AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested
- Feasible for automatic optical inspection (AOI)

Product Summary

V_{DS}	100	V
$R_{DS(on),max}^{3)}$	61	mΩ
I_D	16	A

PG-TDSON-8-10



Type	Package	Marking
IPG16N10S4-61A	PG-TDSON-8-10	4N1061

Maximum ratings, at $T_J=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current one channel active	I_D	$T_C=25\text{ °C}$, $V_{GS}=10\text{ V}$	16	A
		$T_C=100\text{ °C}$, $V_{GS}=10\text{ V}^{1)}$	11	
Pulsed drain current ¹⁾ one channel active	$I_{D,pulse}$	-	64	
Avalanche energy, single pulse ^{1, 3)}	E_{AS}	$I_D=8\text{ A}$	33	mJ
Avalanche current, single pulse ³⁾	I_{AS}	-	10	A
Gate source voltage	V_{GS}	-	±20	V
Power dissipation one channel active	P_{tot}	$T_C=25\text{ °C}$	29	W
Operating and storage temperature	T_j , T_{stg}	-	-55 ... +175	°C

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics¹⁾

Thermal resistance, junction - case	R_{thJC}	-	-	-	5.2	K/W
SMD version, device on PCB	R_{thJA}	minimal footprint	-	100	-	
		6 cm ² cooling area ²⁾	-	60	-	

Electrical characteristics, at $T_j=25^\circ\text{C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=1mA$	100	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=9\mu A$	2.0	2.8	3.5	
Zero gate voltage drain current ⁴⁾	I_{DSS}	$V_{DS}=100V, V_{GS}=0V, T_j=25^\circ\text{C}$	-	0.01	1	μA
		$V_{DS}=100V, V_{GS}=0V, T_j=125^\circ\text{C}^{2)}$	-	1	100	
Gate-source leakage current ³⁾	I_{GSS}	$V_{GS}=20V, V_{DS}=0V$	-	-	100	nA
Drain-source on-state resistance ³⁾	$R_{DS(on)}$	$V_{GS}=10V, I_D=16A$	-	53	61	m Ω

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics¹⁾

Input capacitance ³⁾	C_{iss}	$V_{GS}=0V, V_{DS}=25V,$ $f=1MHz$	-	374	490	pF
Output capacitance ³⁾	C_{oss}		-	120	156	
Reverse transfer capacitance ³⁾	C_{rss}		-	10	20	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=50V, V_{GS}=10V,$ $I_D=16A, R_G=11\Omega$	-	3	-	ns
Rise time	t_r		-	1	-	
Turn-off delay time	$t_{d(off)}$		-	5	-	
Fall time	t_f		-	5	-	

Gate Charge Characteristics^{1, 3)}

Gate to source charge	Q_{gs}	$V_{DD}=50V, I_D=16A,$ $V_{GS}=0 \text{ to } 10V$	-	2	2.6	nC
Gate to drain charge	Q_{gd}		-	1.3	2.6	
Gate charge total	Q_g		-	5.4	7	
Gate plateau voltage	$V_{plateau}$		-	5.4	-	V

Reverse Diode

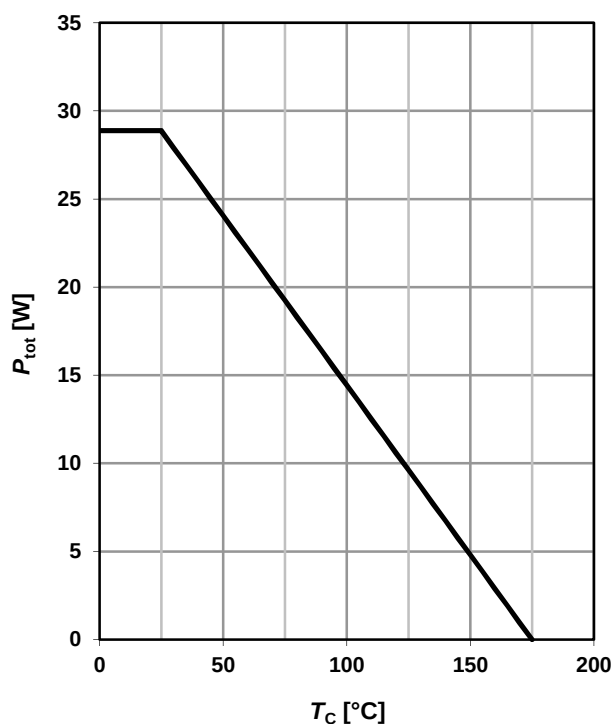
Diode continuous forward current ¹⁾ one channel active	I_S	$T_C=25^\circ C$	-	-	16	A
Diode pulse current ¹⁾ one channel active	$I_{S,pulse}$		-	-	64	
Diode forward voltage	V_{SD}	$V_{GS}=0V, I_F=16A,$ $T_J=25^\circ C$	-	1.0	1.3	V
Reverse recovery time ¹⁾	t_{rr}	$V_R=50V, I_F=I_S,$ $di_F/dt=100A/\mu s$	-	50	-	ns
Reverse recovery charge ^{1, 3)}	Q_{rr}		-	70	-	nC

¹⁾ Specified by design. Not subject to production test.

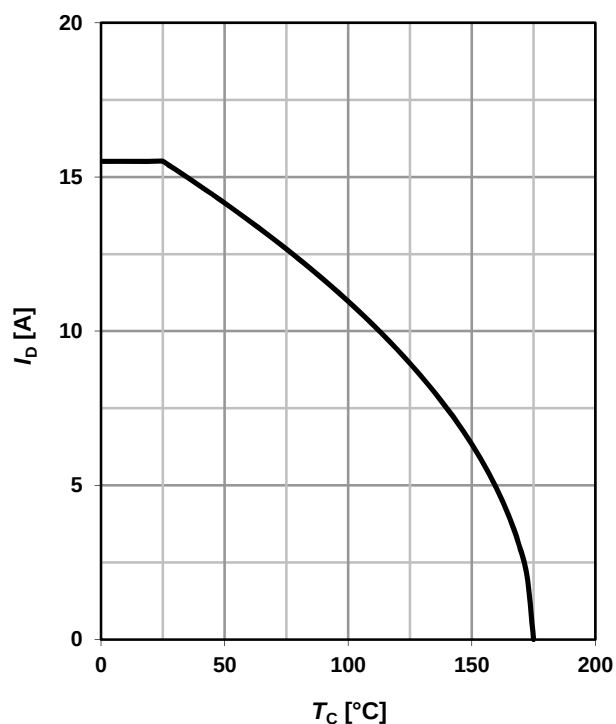
²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ Per channel

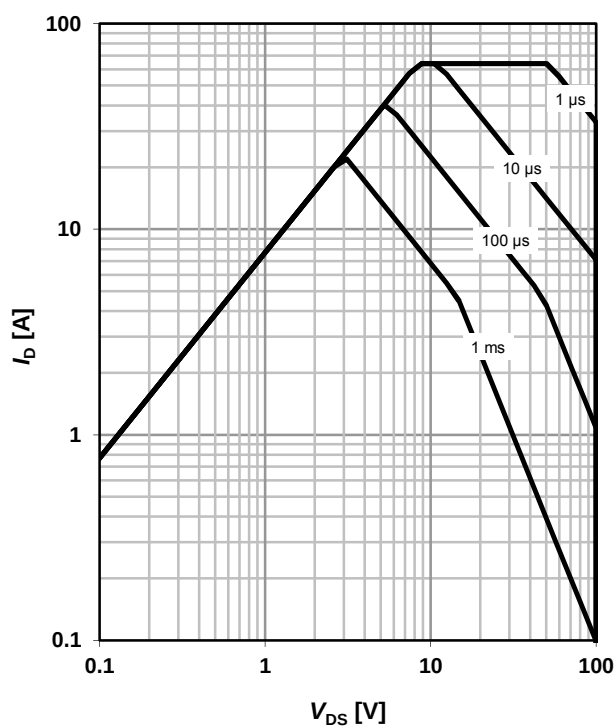
1 Power dissipation

 $P_{\text{tot}} = f(T_C); V_{\text{GS}} \geq 6 \text{ V}; \text{ one channel active}$


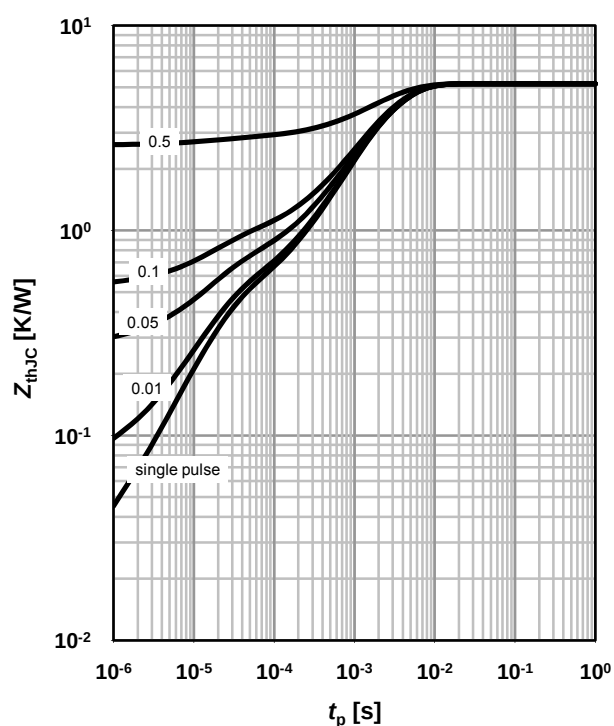
2 Drain current

 $I_D = f(T_C); V_{\text{GS}} \geq 6 \text{ V}; \text{ one channel active}$


3 Safe operating area

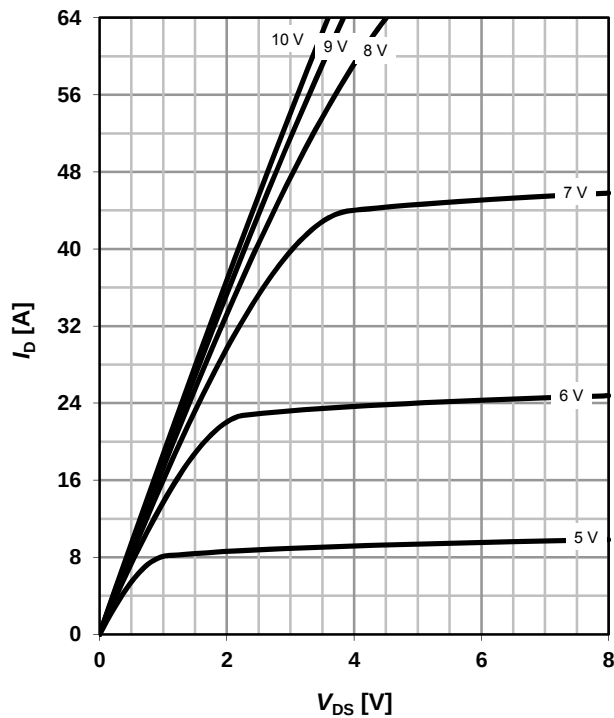
 $I_D = f(V_{\text{DS}}); T_C = 25^\circ\text{C}; D = 0; \text{ one channel active}$
parameter: t_p


4 Max. transient thermal impedance

 $Z_{\text{thJC}} = f(t_p)$
parameter: $D = t_p/T$


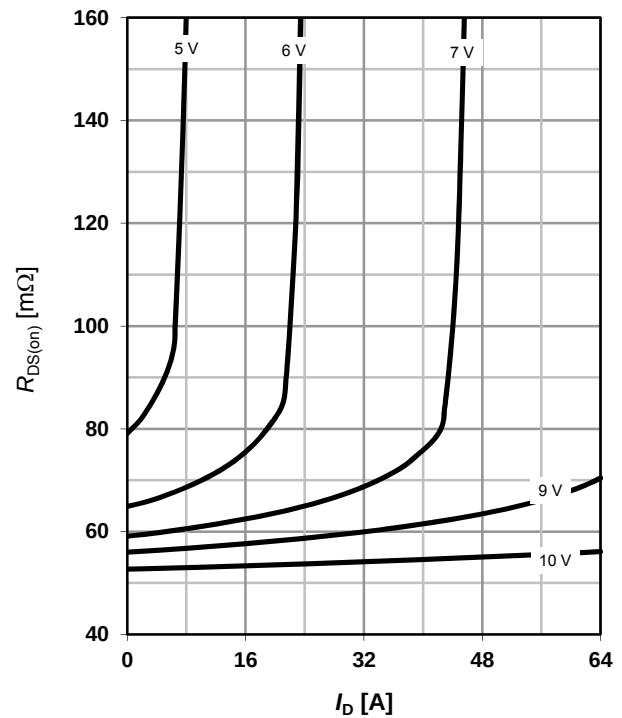
5 Typ. output characteristics⁵⁾

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}$

parameter: V_{GS}


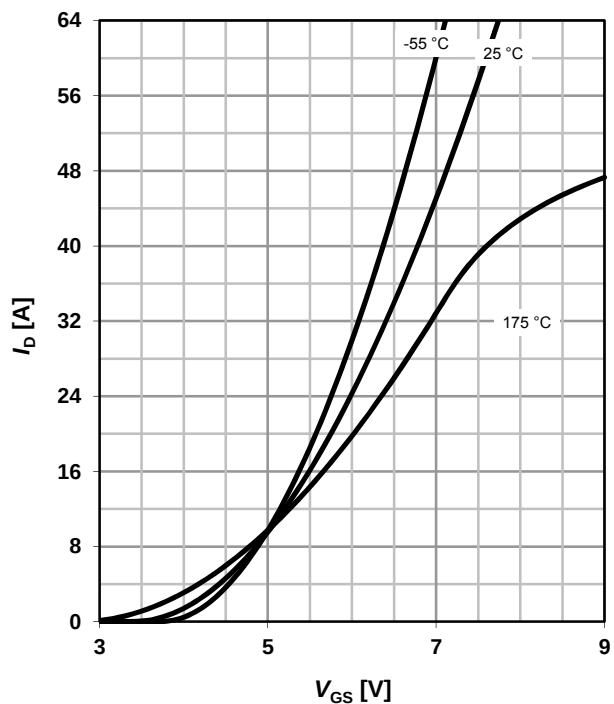
6 Typ. drain-source on-state resistance⁵⁾

 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$

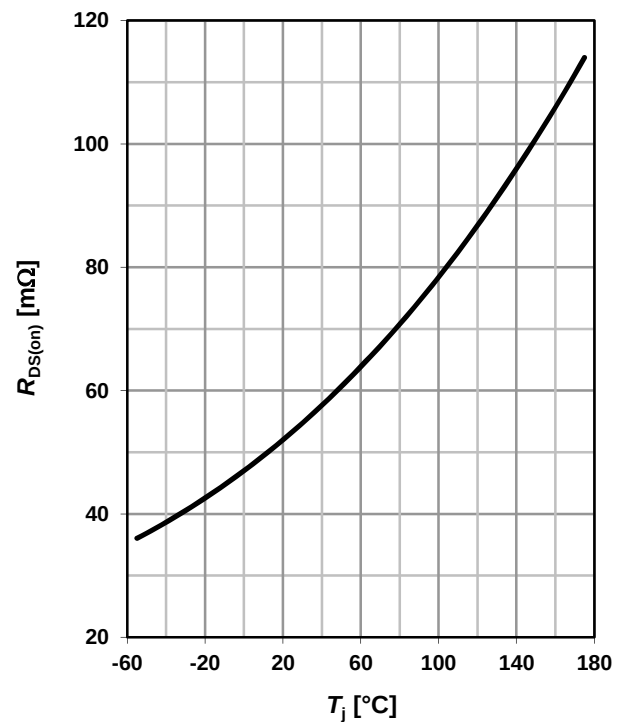
parameter: V_{GS}


7 Typ. transfer characteristics⁵⁾

 $I_D = f(V_{GS}); V_{DS} = 6\text{V}$

parameter: T_j


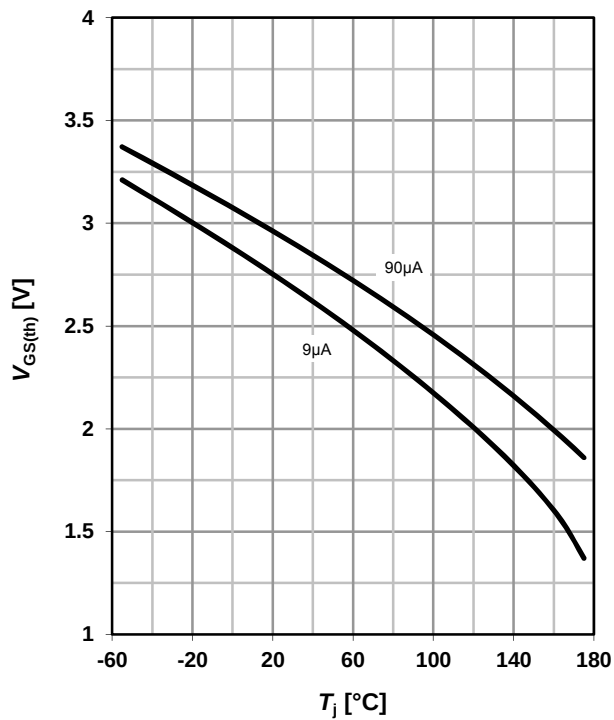
8 Typ. drain-source on-state resistance⁵⁾

 $R_{DS(on)} = f(T_j); I_D = 16\text{A}; V_{GS} = 10\text{V}$


9 Typ. gate threshold voltage

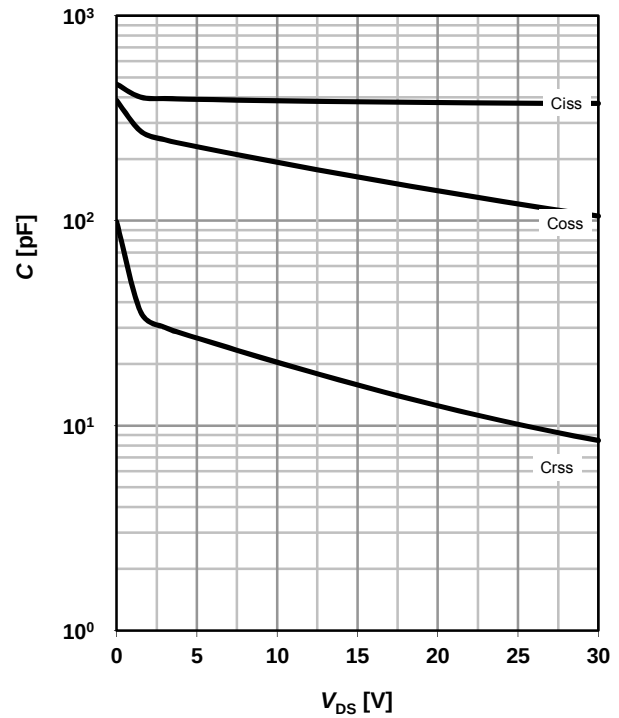
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter: I_D



10 Typ. Capacitances⁵⁾

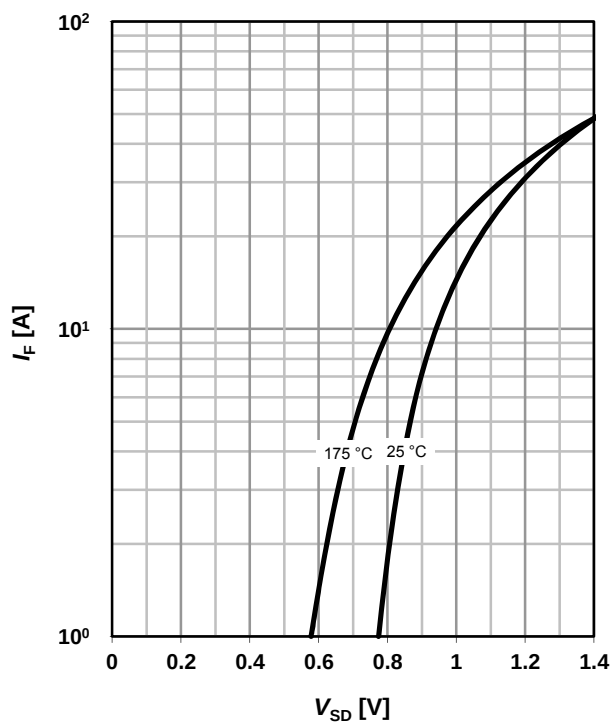
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



11 Typical forward diode characteristics⁵⁾

$$I_F = f(V_{SD})$$

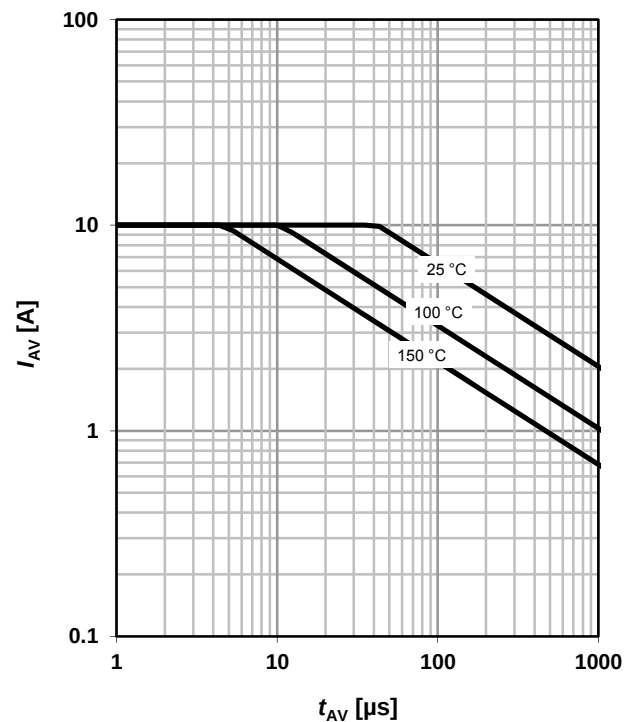
parameter: T_j



12 Avalanche characteristics⁵⁾

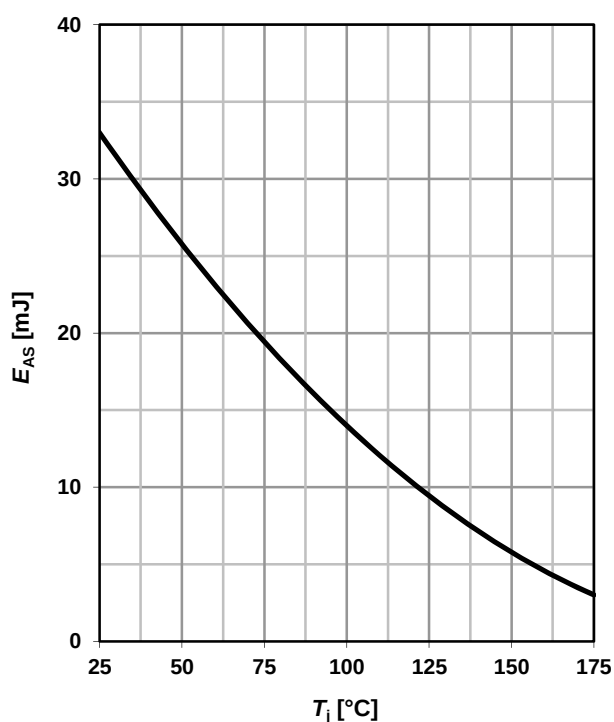
$$I_{AS} = f(t_{AV})$$

parameter: $T_{j(start)}$



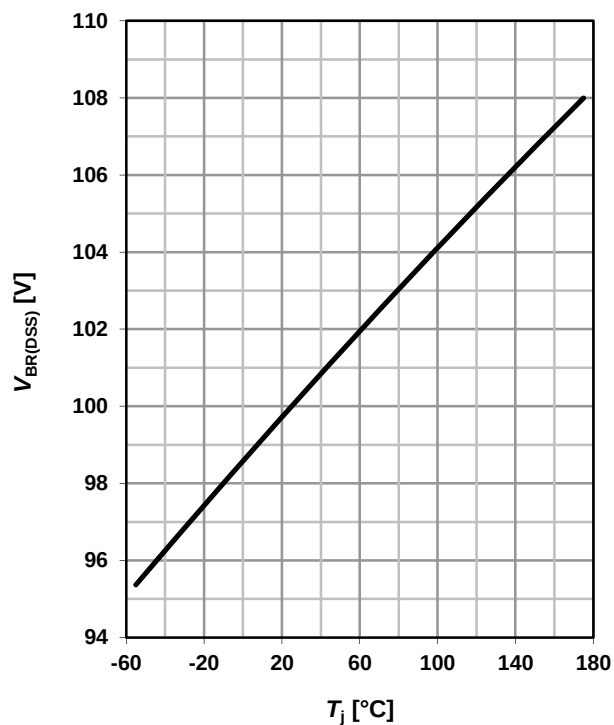
13 Avalanche energy⁵⁾

$$E_{AS} = f(T_j), I_D = 8A$$



14 Drain-source breakdown voltage

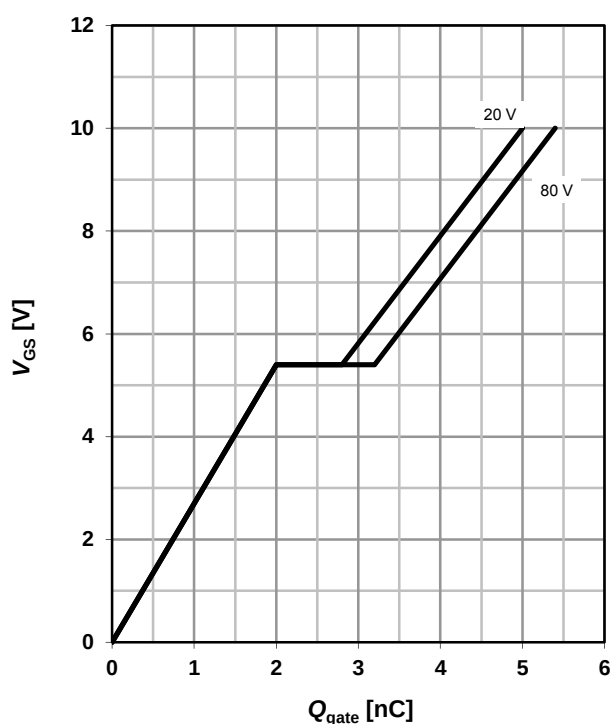
$$V_{BR(DSS)} = f(T_j); I_D = 1 mA$$



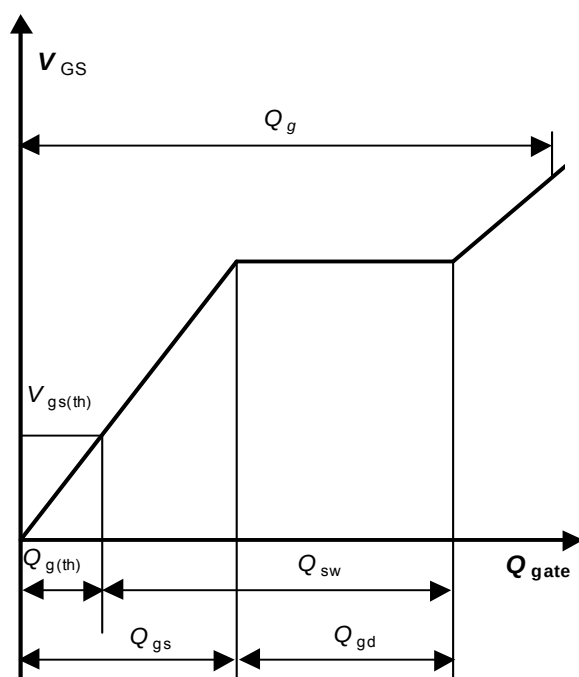
15 Typ. gate charge⁵⁾

$$V_{GS} = f(Q_{gate}); I_D = 16 A \text{ pulsed}$$

parameter: V_{DD}



16 Gate charge waveforms



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Revision History

Version	Date	Changes
Revision 1.0	04.03.2013	Final Data Sheet

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